



Flip Chip Technologies

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Chip Interconnection 방법

1. Wire Bonding
2. Tape Automated Bonding (TAB)
3. Flip Chip Bonding



Wire Bonding

- the most common chip interconnection technique

(특징)

- 경제적, 생산성 우수 (automation)
- good flexibility and reliability
- I/O density의 제한 (< 300)
- inductance 발생 (wire의 길이를 줄여야)

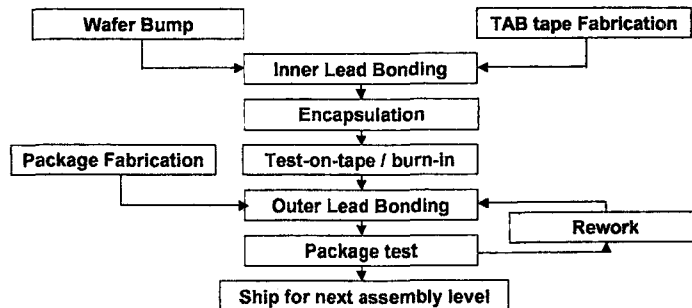
(공정 방법)

- Thermocompression method
- Ultrasonic method
- Thermosonic method



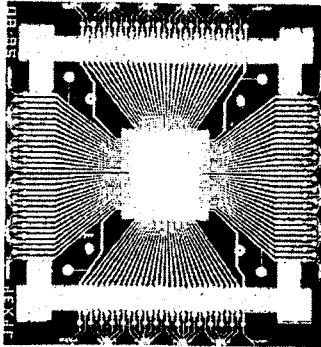
Tape-Automated-bonding (TAB) process

높은 실장 밀도, 다핀화 가능
박막화 가능 (IC Card, LCD용)
일괄 본딩 가능 (gang bonding)
Test와 burn-in등을 assembly 중간에 가능
Module 화 가능

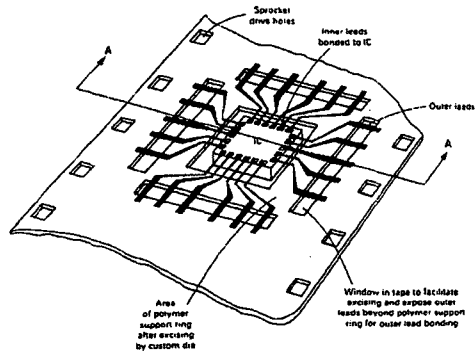




Tape Automated Bonding (TAB)



TAB tape

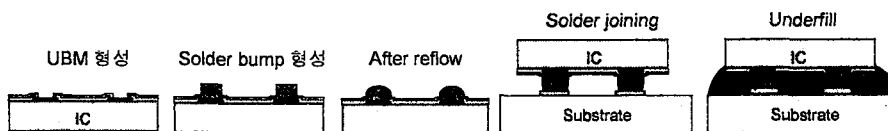
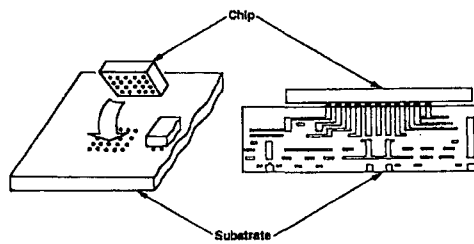


Bonding 된 모양



Flip Chip Technology

- IBM C4 Process (Controlled-Collapse Chip Connection)





Flip Chip Technology

● Definition

the direct electrical interconnection of electronic components onto substrates by means of bumps

● Application

- Flip chip components
- Semiconductor device
 - Passive component
 - Detector arrays
 - MEMs device

● Characteristics

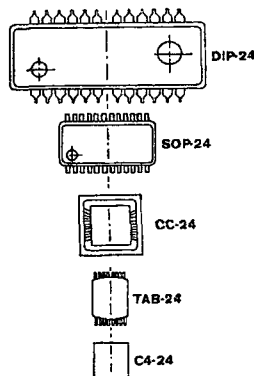
- Smallest Size
- Greatest I/O Flexibility
- Highest Performance
- Reliable

● Function

- electrically conductive path between the chip and the substrate rate
- thermally conductive path to carry from the chip to the substrates
- mechanical mounting of the die to the substrate
- a spacer preventing electrical conduct between the chip and substrate conduct



Space Efficiency by IC Package Type



Package Space (16K CMOS SRAM)

	DIP-24	SOP-24	CC-24	TAB-24	C4-24
mm X mm	31.0 X 15.24	15.4 X 10.24	11.18 X 11.18	5.65 X 8.87	5.65 X 6.57
mm ²	472.44	157.70	124.99	60.12	37.12
Ratio	12.73	4.25	3.37	1.35	1



History of Flip Chip Technologies (IBM)

- **1st Generation**

- Solid logic Technology
 - Cu micro-ball / high mp solder
 - Application to the transistors (1961)
 - Production in the IBM system 360 (1964)

- **2nd Generation**

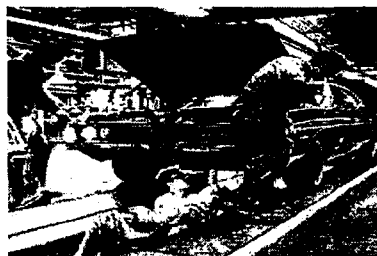
- Controlled collapse Chip Connection (1970)



History of Flip Chip Technology (GM)

- **GM's Delco Division (now Delphi Delco in Kokomo, Ind.)**

- Electroplated Ag bumps
- Au/Cr UBM on the passivated die
- Voltage regulator under the hood of 1969 Pontiac automobile



(Source : Chip scale Review)



Flip Chip Solder Joining 기술

- Chip surface (active area) facing to the substrate
- Solder bump : electrical and mechanical interconnection

장점

- High I/O density
- Chip packaging 밀도 높음
- Short interconnection length → 전기적 특성 우수
- 신뢰도가 큼 (under fill 공정 적용)
- Self alignment

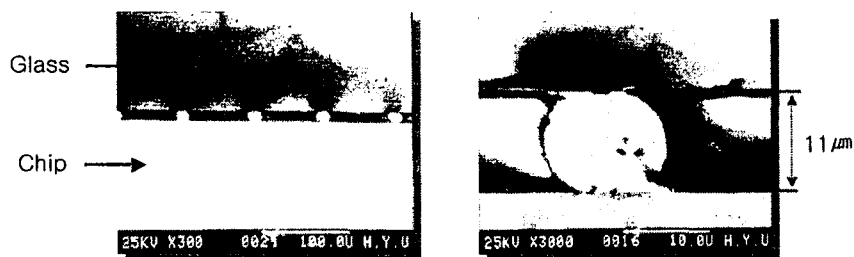
단점

- Process complexity → Higher Cost
- Thermal strain → fatigue
- Joining 후 optical inspection 불가



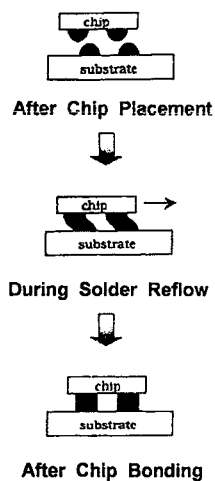
SEM Image of Solder Joints

✓ In-Ag solder on Au/Cu/Cr (50 μm pitch)

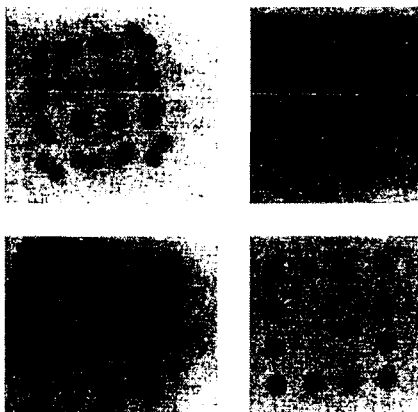




Solder의 Self-Alignment Effect



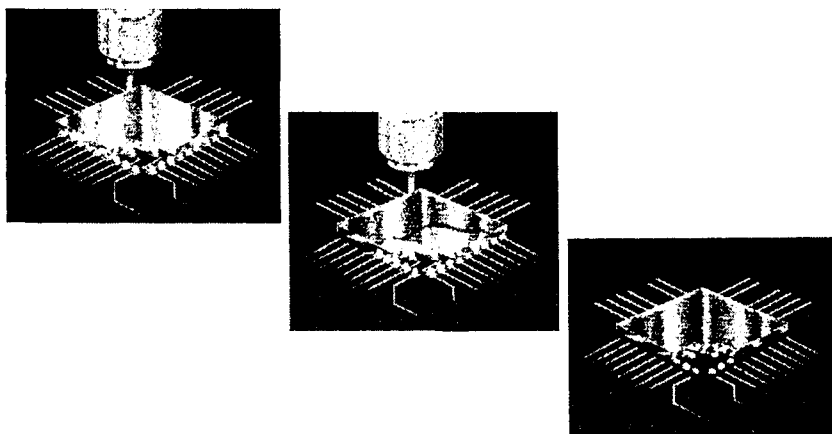
X-ray images



(Source : Flip Chip Technologies)



Underfill Process





Under Bump Metallurgy(UBM) or Ball limiting Metallurgy(BLM)

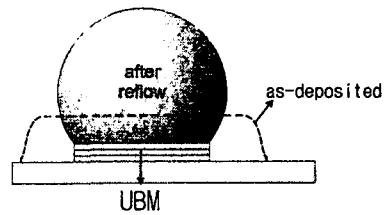
Solder를 Al Pad위에 Wetting

- Adhesion/ Barrier layer, Wetting layer, Oxide Prevention layer로 구성
- 제조방법 : Evaporation, Sputtering, Plating
- Metallurgy

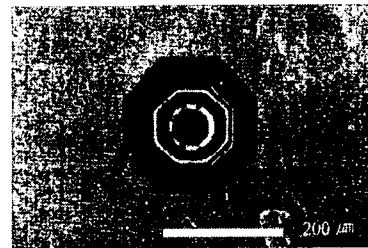
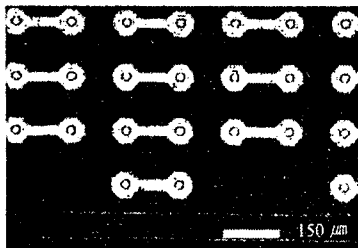
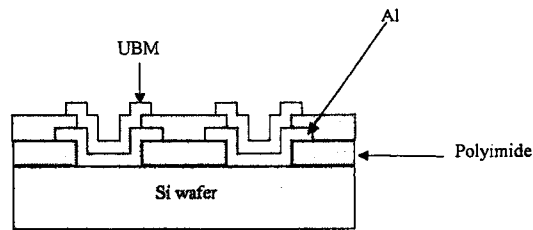
Adhesion layer : Cr, Ti, TiW, Al

Wetting layer : Cu, Ni, Pd, Pt

Oxide Prevention layer : Au



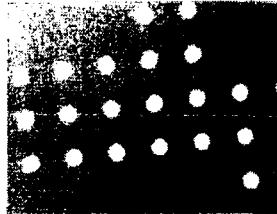
형성된 UBM pad



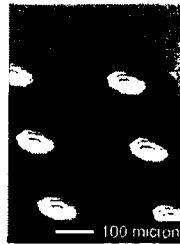


UBM patterns

- Optical image



- SEM images



Solder Bump

- 기 능
 - Chip과 Substrate 사이의 Electrical and Mechanical Connection
 - Chip으로 부터의 Heat Dissipation Path

- 재 료
 - Eutectic Pb-Sn, Pb-Sn-Ag
 - High Pb-5 ~ 10 %Sn
 - Pb-In(50/50)
 - In
 - Pb-Free solders (Sn-Ag-Cu, Sn-Cu 등)



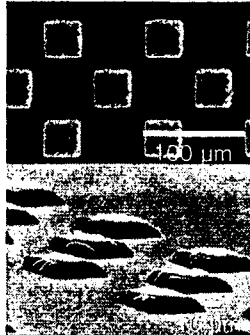
Figure 1. Standard flip chip array with eutectic Sn/Pb solder bumps



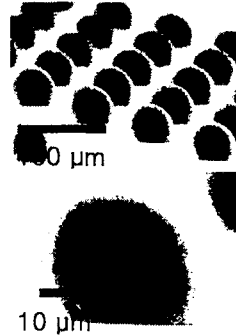
주요 Solder bump 제조 방법

- Evaporation
- Electroplating
- Solder paste print
- Jetting
- Stud bumping

Before Reflow



After Reflow



Evaporation을 이용한 Solder Bump 형성

- UBM과 솔더를 금속 마스크를 이용하여 순서대로 **evaporation**
 - 가장 오래된 방법, 신뢰성 있음
 - 두께, 조성 조절이 쉽다.
 - 고가의 장비 필요, 공정 비용이 비쌈
 - 3상이상의 합금 조성제어가 힘들 → reflow 필요

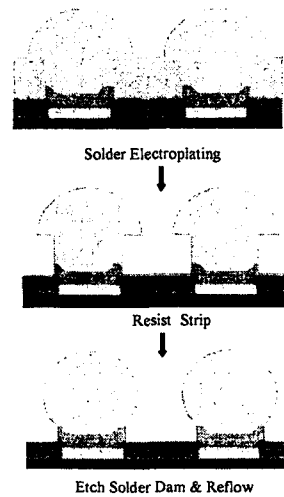
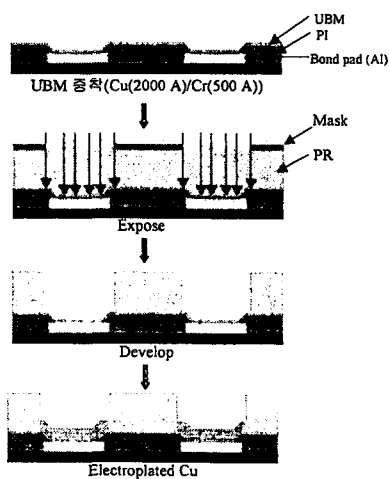


전기도금 방법에 의한 Solder Bump 형성

- Evaporation 방법에 비해 시설비가 적게 들고 가격이 싸다.
- 미세 범프 형성이 용이
- 도금 공정에 의한 응력 발생 가능 ➡ 신뢰도 저하
- 위치에 따른 솔더 두께, 조성 차이 발생 가능성
- 도금 중 수소 기체가 솔더 내에 trap ➡ pore 발생가능



전기도금에 의한 Solder Bump Formation Process





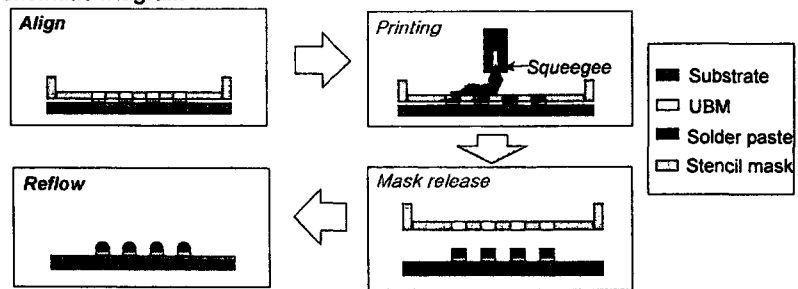
Stencil Printing 방법에 의한 Bump 형성 방법

- Stencil mask를 이용하여 Solder Paste를 도포
 - 3상 이상의 솔더 범프 형성 가능하며 조성 조절이 쉽다.
 - Reflow공정 생략 가능
 - 가격 경쟁력 큼
 - 미세 피치 힘들다.

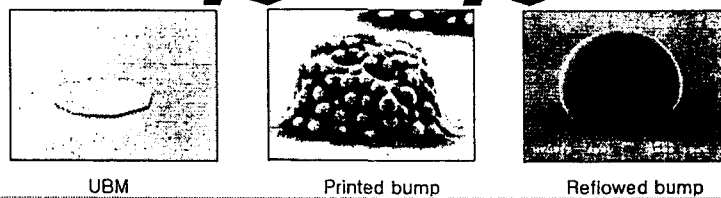


Stencil Printing Process

Schematic Diagram

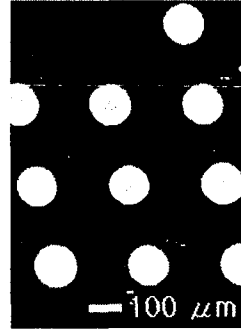
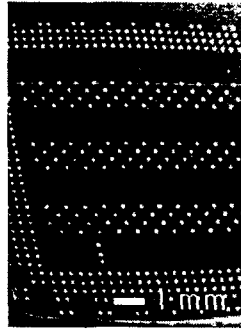


SEM images





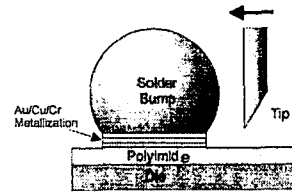
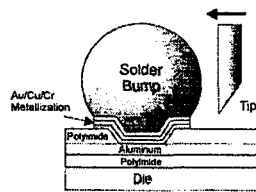
SEM image of the solder bumps after reflow



Height : 107 μm, Diameter : 124 μm



Shear Test Methods



Dage BT-2400

Tip speed : 0.11 mm/s

Tip height : 10 μm

Process capability

$$C_{pk} = \left| \frac{\bar{x} - s}{3\sigma} \right|$$

\bar{x} : the average value

s : the specified value

σ : the standard deviation

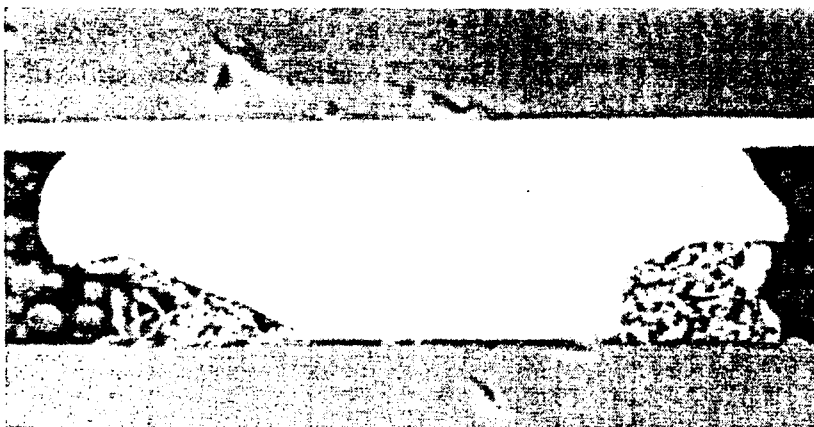


Stud Bump Flip Chip Technology

- **Bumping**
 - Stud bump material
Au, Pt, Cu
- **Connection to the substrate**
 - Conductive adhesives bonding
 - Non-conductive adhesive bonding
 - Ultrasonic or thermosonic bonding
 - Solder paste, plated solder reflow
- **Advantage and limitations**
 - Stud bump formed easily by wire bonders
 - Bumping equipment is widely available and well characterized
 - UBM not required
 - Fast, efficient, and flexible for low to medium production
 - Easy to scale up to high volume production
 - Serial process
 - Increasing bumping time with the number of bumps
 - More precise die bonder than self-aligning solder assemblies



Stud Bump Technology with Conductive Adhesive



(Source : Flipchips.com)

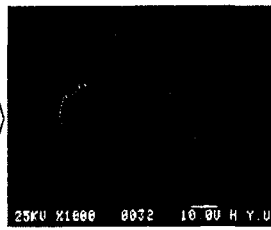


Stud Bump Bonding Process

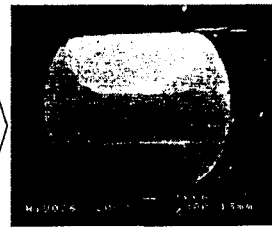
- Create conductive bumps on the die bond pads
- Coined (Flattened) the stud bumps by mechanical pressure
- Connect the die to the substrate
- Underfill



Stud bump formation



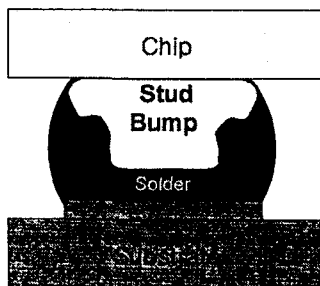
After Leveling



After Joining and Underfill



Stud Bump Bonding with Solder Paste



Maskless process without special tooling costs

Under bump metallurgy not necessary

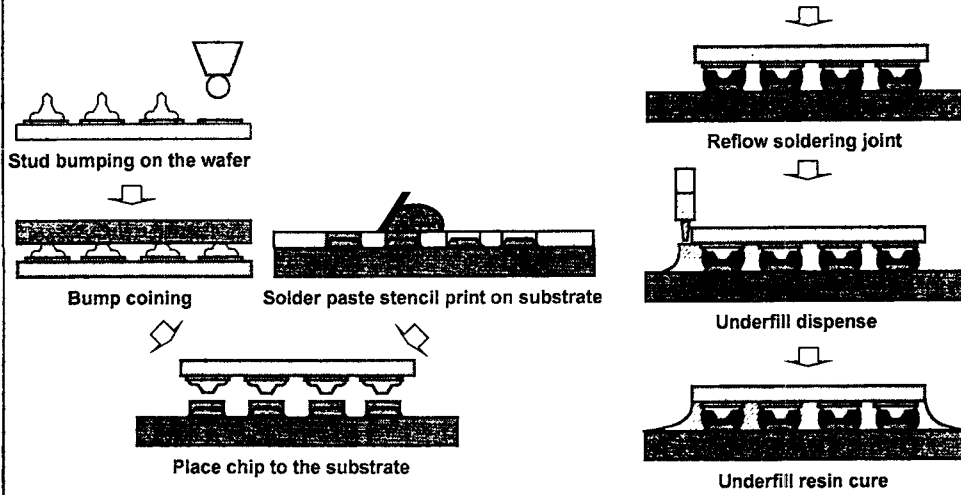
• Fine pitch & chip level bumping possible

• Self-aligning possible

➔ Low cost Flip Chip Technology



Overall process

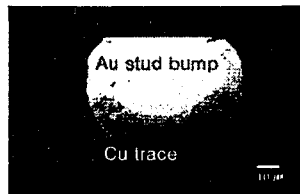


Cross sectional view of solder joints (BSE images)

The 1st reflow



Specimen # 1



Specimen # 2

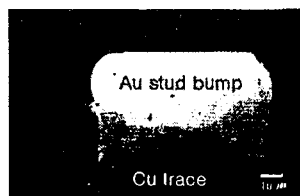


Specimen # 3

Multiple reflows



The 2nd reflow



The 3rd reflow

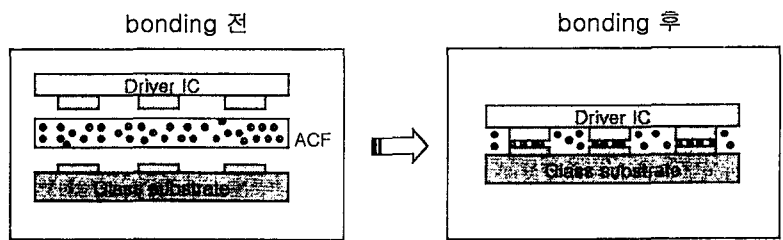


The 5th reflow



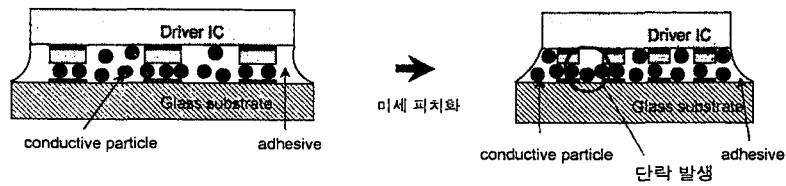
Chip On Glass (COG) Technology

- Driver IC interconnection on LCD module
- Anisotropic Conductive Adhesive Film (ACF) 이용
- 특 징
 - Fine Pitch
 - Low Cost
 - Low Profile
 - Low Temperature Process



Pitch의 미세화에 따른 문제점과 해결책

- Pitch의 미세화에 따른 문제점
 - ➔ 인접 전극간의 단락



Pitch의 미세화에 따른 문제점의 해결책

